

MOSFET – Dual, N-Channel, POWERTRENCH®

30 V, 9.5 mΩ and 20 mΩ

FDMC8200

General Description

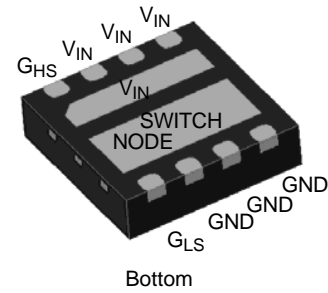
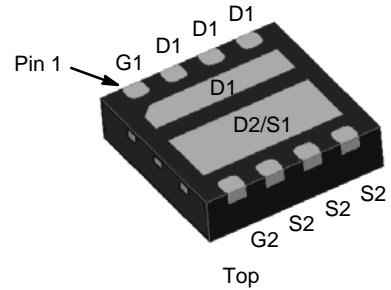
This device includes two specialized N-Channel MOSFETs in a dual Power33 (3 mm x 3 mm MLP) package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous MOSFET (Q2) have been designed to provide optimal power efficiency.

Features

- Q1: N-Channel
 - ◆ Max $r_{DS(on)}$ = 20 mΩ at $V_{GS} = 10\text{ V}$, $I_D = 6\text{ A}$
 - ◆ Max $r_{DS(on)}$ = 32 mΩ at $V_{GS} = 4.5\text{ V}$, $I_D = 5\text{ A}$
- Q2: N-Channel
 - ◆ Max $r_{DS(on)}$ = 9.5 mΩ at $V_{GS} = 10\text{ V}$, $I_D = 9\text{ A}$
 - ◆ Max $r_{DS(on)}$ = 13.5 mΩ at $V_{GS} = 4.5\text{ V}$, $I_D = 7\text{ A}$
- This Device is Pb-Free, Halide Free and is RoHS Compliant

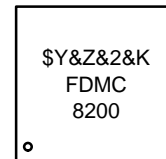
Applications

- Mobile Computing
- Mobile Internet Devices
- General Purpose Point of Load



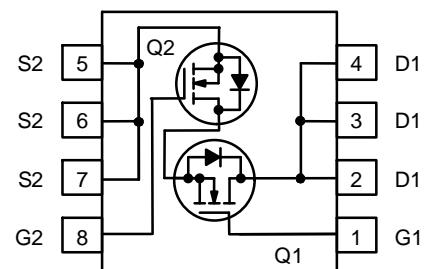
WDFN8 3x3, 0.65P
(Power 33)
CASE 511DE

MARKING DIAGRAM



- \$Y = Logo
- &Z = Assembly Plant Code
- &2 = 2-Digit Date Code
- &K = 2-Digits Lot Run Traceability Code
- FDMC8200 = Device Code

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 9 of this data sheet.

FDMC8200

MOSFET MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise noted)

| Symbol | Parameter | Q1 | Q2 | Unit |
|----------------|---|---------------|---------------|------------------|
| V_{DS} | Drain to Source Voltage | 30 | 30 | V |
| V_{GS} | Gate to Source Voltage (Note 3) | ± 20 | ± 20 | V |
| I_D | Drain Current – Continuous (Package Limited) $T_C = 25^\circ\text{C}$ | 18 | 18 | A |
| | – Continuous (Silicon Limited) $T_C = 25^\circ\text{C}$ | 23 | 45 | |
| | – Continuous $T_A = 25^\circ\text{C}$ | 8 (Note 1a) | 12 (Note 1b) | |
| | – Pulsed | 40 | 40 | |
| P_D | Power Dissipation $T_A = 25^\circ\text{C}$ | 1.9 (Note 1a) | 2.2 (Note 1b) | W |
| | Power Dissipation $T_A = 25^\circ\text{C}$ | 0.7 (Note 1c) | 0.9 (Note 1d) | |
| T_J, T_{STG} | Operating and Storage Junction Temperature Range | –55 to +150 | | $^\circ\text{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$, unless otherwise noted)

| Symbol | Parameter | Q1 | Q2 | Unit |
|-----------------|---|---------------|---------------|---------------------------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 65 (Note 1a) | 55 (Note 1b) | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 180 (Note 1c) | 145 (Note 1d) | |
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 7.5 | 4 | |

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Test Conditions | Type | Min | Typ | Max | Unit |
|--------|-----------|-----------------|------|-----|-----|-----|------|
|--------|-----------|-----------------|------|-----|-----|-----|------|

OFF CHARACTERISTICS

| | | | | | | | |
|--------------------------------------|---|--|----|----|----|-----|----------------------------|
| BV_{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu\text{A}, V_{GS} = 0 \text{ V}$ $I_D = 250 \mu\text{A}, V_{GS} = 0 \text{ V}$ | Q1 | 30 | – | – | V |
| | | | Q2 | 30 | – | – | |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu\text{A}$, referenced to 25°C $I_D = 250 \mu\text{A}$, referenced to 25°C | Q1 | – | 14 | – | $\text{mV}/^\circ\text{C}$ |
| | | | Q2 | – | 14 | – | |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ | Q1 | – | – | 1 | μA |
| | | | Q2 | – | – | 1 | |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20 \text{ V}, V_{GS} = 0 \text{ V}$ | Q1 | – | – | 100 | nA |
| | | | Q2 | – | – | 100 | |

ON CHARACTERISTICS

| | | | | | | | |
|--|--|--|----|-----|-----|------|----------------------------|
| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$ $V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$ | Q1 | 1.0 | 2.3 | 3.0 | V |
| | | | Q2 | 1.0 | 2.3 | 3.0 | |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250 \mu\text{A}$, referenced to 25°C $I_D = 250 \mu\text{A}$, referenced to 25°C | Q1 | – | –5 | – | $\text{mV}/^\circ\text{C}$ |
| | | | Q2 | – | –6 | – | |
| $r_{DS(on)}$ | Static Drain to Source On Resistance | $V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}, T_J = 125^\circ\text{C}$ | Q1 | – | 16 | 20 | $\text{m}\Omega$ |
| | | | | – | 24 | 32 | |
| | | | Q2 | – | 7.3 | 9.5 | |
| | | | | – | 9.5 | 13.5 | |
| g_{FS} | Forward Transconductance | $V_{DD} = 5 \text{ V}, I_D = 6 \text{ A}$ $V_{DD} = 5 \text{ V}, I_D = 9 \text{ A}$ | Q1 | – | 29 | – | S |
| | | | Q2 | – | 56 | – | |

DYNAMIC CHARACTERISTICS

| | | | | | | | |
|-----------|------------------------------|--|----|---|------|------|----|
| C_{iss} | Input Capacitance | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | Q1 | – | 495 | 660 | pF |
| | | | Q2 | – | 1180 | 1570 | |
| C_{oss} | Output Capacitance | | Q1 | – | 145 | 195 | pF |
| | | | Q2 | – | 330 | 440 | |
| C_{rss} | Reverse Transfer Capacitance | | Q1 | – | 20 | 30 | pF |
| | | | Q2 | – | 30 | 45 | |

FDMC8200

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

| Symbol | Parameter | Test Conditions | Type | Min | Typ | Max | Unit |
|--------|-----------|-----------------|------|-----|-----|-----|------|
|--------|-----------|-----------------|------|-----|-----|-----|------|

DYNAMIC CHARACTERISTICS

| | | | | | | | |
|----------------|-----------------|-----------|----|---|-----|---|---|
| R _g | Gate Resistance | f = 1 MHz | Q1 | – | 1.4 | – | Ω |
| | | | Q2 | – | 1.4 | – | |

SWITCHING CHARACTERISTICS

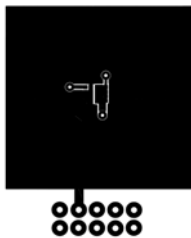
| | | | | | | | |
|---------------------|-------------------------------|--|----|---|-----|-----|----|
| t _{d(on)} | Turn-On Delay Time | Q1 V _{DD} = 15 V, I _D = 1 A, V _{GS} = 10 V, R _{GEN} = 6 Ω Q2 V _{DD} = 15 V, I _D = 1 A, V _{GS} = 10 V, R _{GEN} = 6 Ω | Q1 | – | 11 | 20 | ns |
| t _r | Rise Time | | Q1 | – | 3.1 | 10 | |
| t _{d(off)} | Turn-Off Delay Time | | Q2 | – | 4 | 10 | |
| t _f | Fall Time | | Q1 | – | 35 | 56 | |
| | | | Q2 | – | 38 | 60 | |
| Q _{g(TOT)} | Total Gate Charge | V _{GS} = 0 V to 10 V Q1: V _{DD} = 15 V, I _D = 6 A Q2: V _{DD} = 15 V, I _D = 9 A | Q1 | – | 7.3 | 10 | nC |
| | | | Q2 | – | 16 | 22 | |
| Q _{g(TOT)} | Total Gate Charge | V _{GS} = 0 V to 4.5 V Q1: V _{DD} = 15 V, I _D = 6 A Q2: V _{DD} = 15 V, I _D = 9 A | Q1 | – | 3.1 | 4.3 | nC |
| | | | Q2 | – | 7 | 10 | |
| Q _{gs} | Gate to Source Charge | Q1: V _{DD} = 15 V, I _D = 6 A | Q1 | – | 1.8 | – | nC |
| | | | Q2 | – | 4.1 | – | |
| Q _{gd} | Gate to Drain "Miller" Charge | Q2: V _{DD} = 15 V, I _D = 9 A | Q1 | – | 1 | – | nC |
| | | | Q2 | – | 1.5 | – | |

DRAIN-SOURCE CHARACTERISTICS

| | | | | | | | |
|-----------------|---------------------------------------|--|----|---|-----|-----|----|
| V _{SD} | Source to Drain Diode Forward Voltage | V _{GS} = 0 V, I _S = 6 A (Note 2) V _{GS} = 0 V, I _S = 9 A (Note 2) | Q1 | – | 0.8 | 1.2 | V |
| | | | Q2 | – | 0.8 | 1.2 | |
| t _{rr} | Reverse Recovery Time | Q1 I _F = 6 A, di/dt = 100 A/μS | Q1 | – | 13 | 24 | ns |
| | | | Q2 | – | 21 | 34 | |
| Q _{rr} | Reverse Recovery Charge | Q2 I _F = 9 A, di/dt = 100 A/μS | Q1 | – | 2.3 | 10 | nC |
| | | | Q2 | – | 5.6 | 12 | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

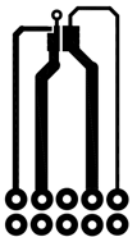
- R_{θJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{θJC} is guaranteed by design while R_{θCA} is determined by the user's board design.



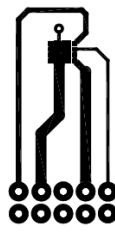
- 65°C/W when mounted on a 1 in² pad of 2 oz copper



- 55°C/W when mounted on a 1 in² pad of 2 oz copper



- 180°C/W when mounted on a minimum pad of 2 oz copper



- 145°C/W when mounted on a minimum pad of 2 oz copper

- Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.
- As an N-ch device, the negative V_{gs} rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

TYPICAL CHARACTERISTICS (Q1 N-CHANNEL) ($T_J = 25^\circ\text{C}$, unless otherwise noted)

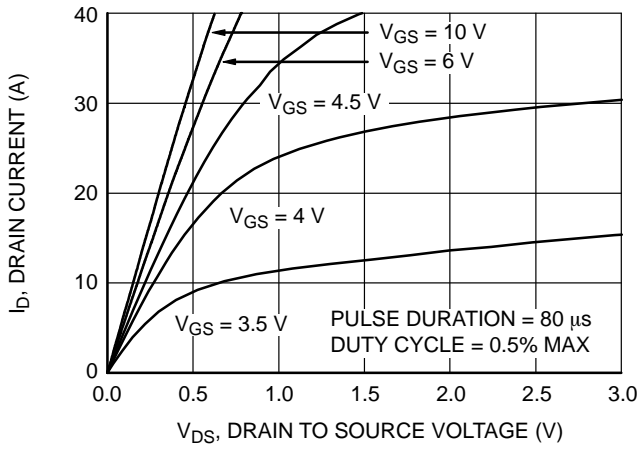


Figure 1. On Region Characteristics

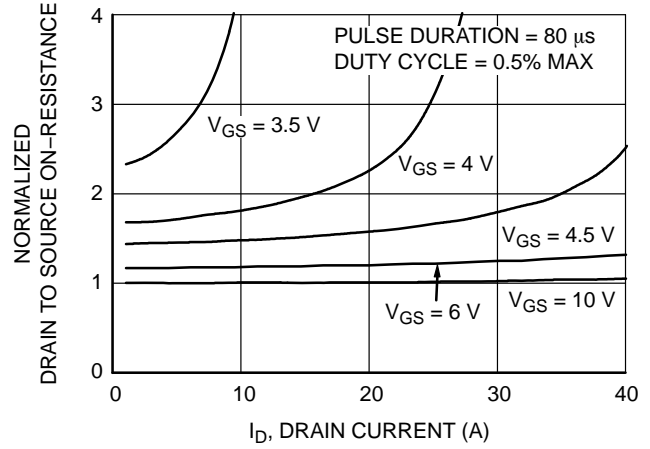


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

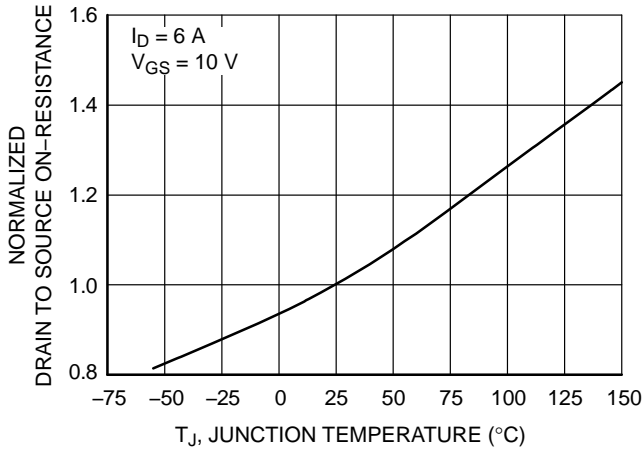


Figure 3. Normalized On Resistance vs. Junction Temperature

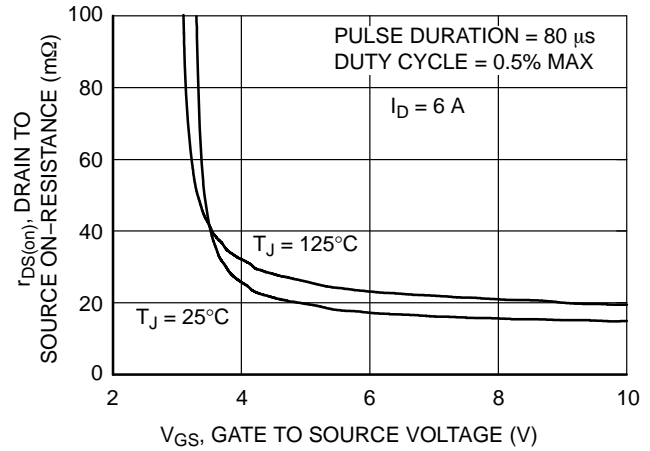


Figure 4. On-Resistance vs. Gate to Source Voltage

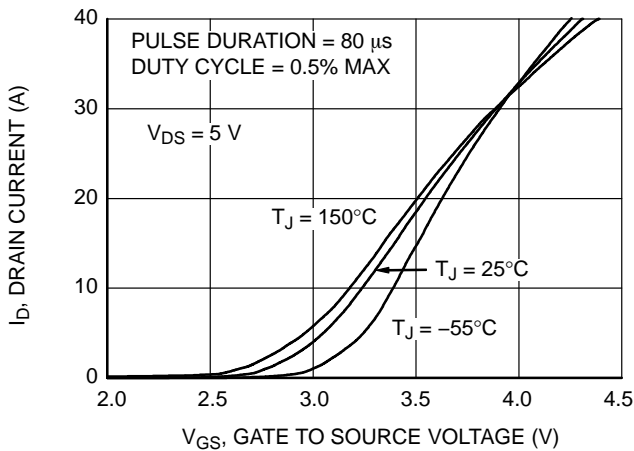


Figure 5. Transfer Characteristics

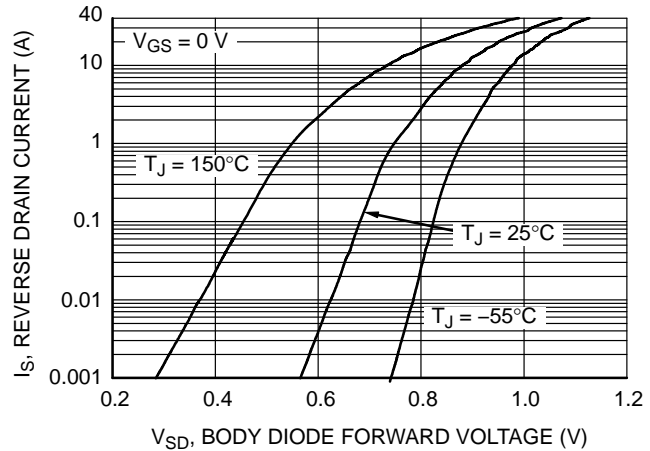


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (Q1 N-CHANNEL) ($T_J = 25^\circ\text{C}$, unless otherwise noted) (continued)

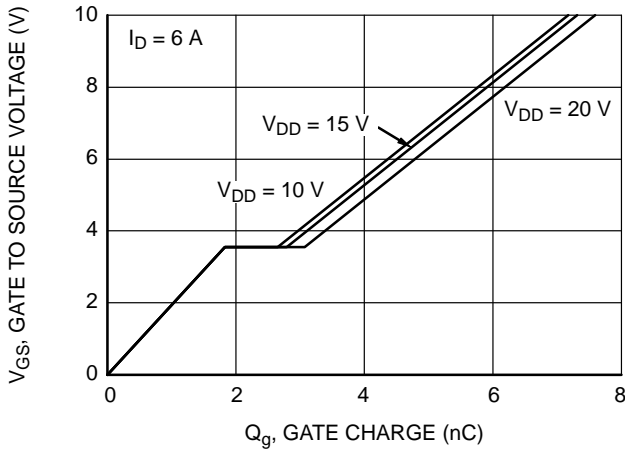


Figure 7. Gate Charge Characteristics

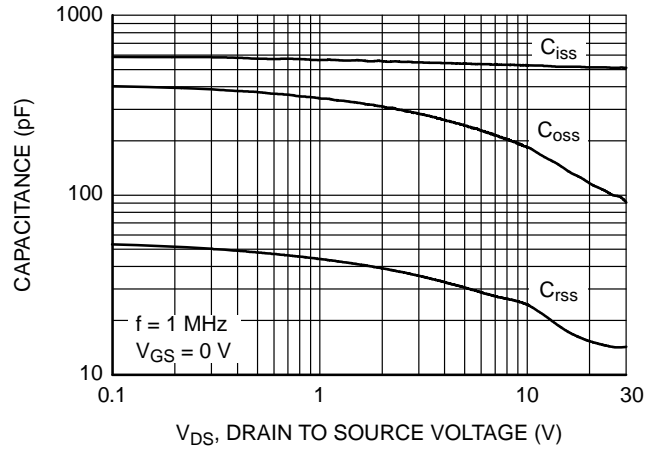


Figure 8. Capacitance vs. Drain to Source Voltage

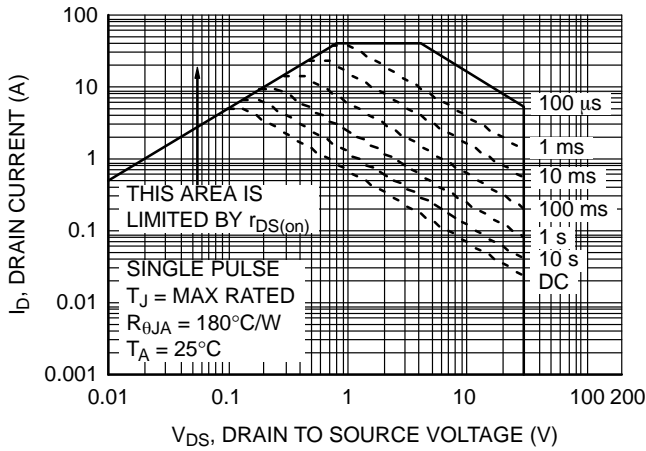


Figure 9. Forward Bias Safe Operating Area

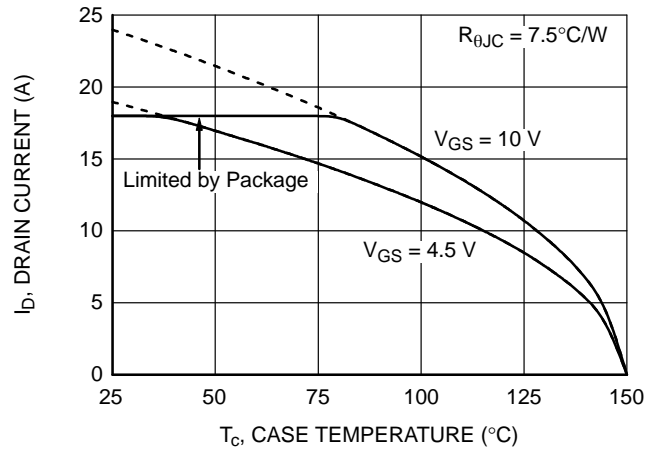


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

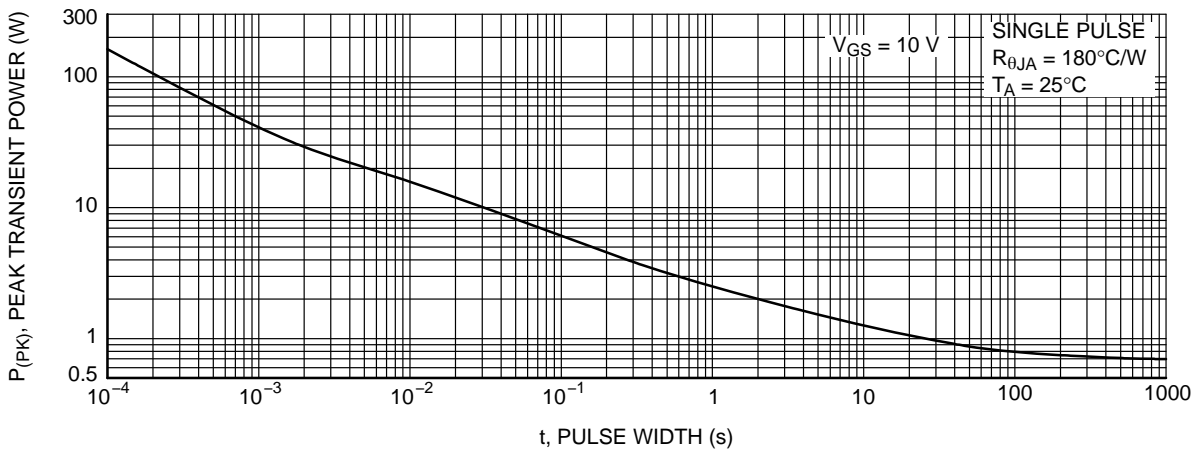


Figure 11. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (Q1 N-CHANNEL) ($T_J = 25^\circ\text{C}$, unless otherwise noted) (continued)

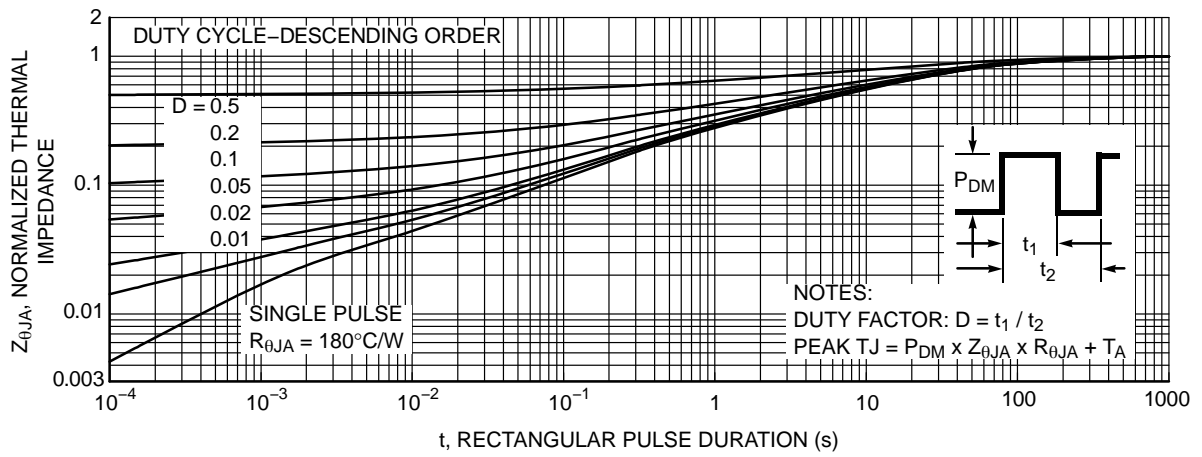


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

TYPICAL CHARACTERISTICS (Q2 N-CHANNEL) ($T_J = 25^\circ\text{C}$, unless otherwise noted)

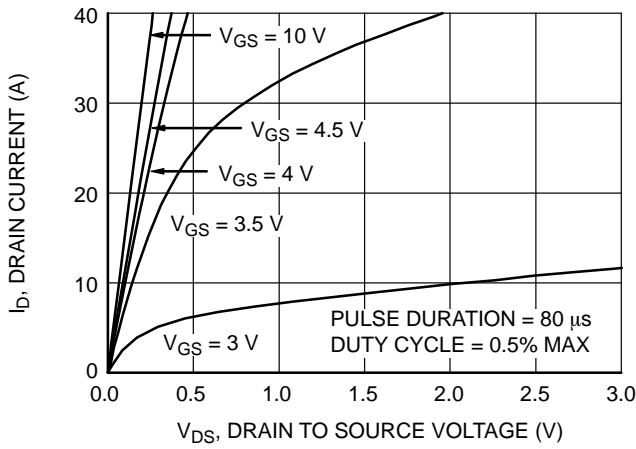


Figure 13. On-Region Characteristics

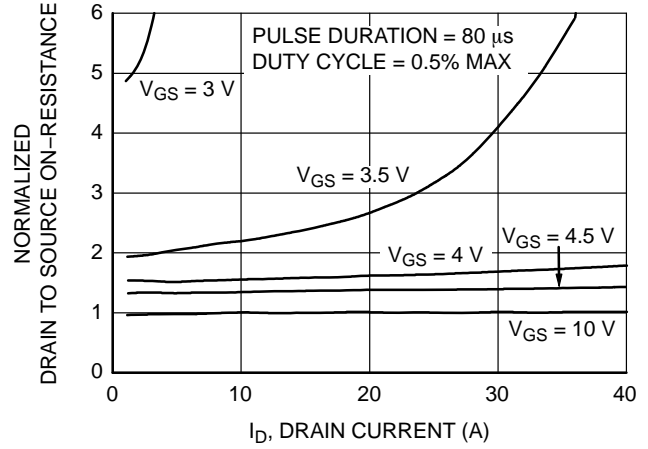


Figure 14. Normalized On-Resistance vs. Drain Current and Gate Voltage

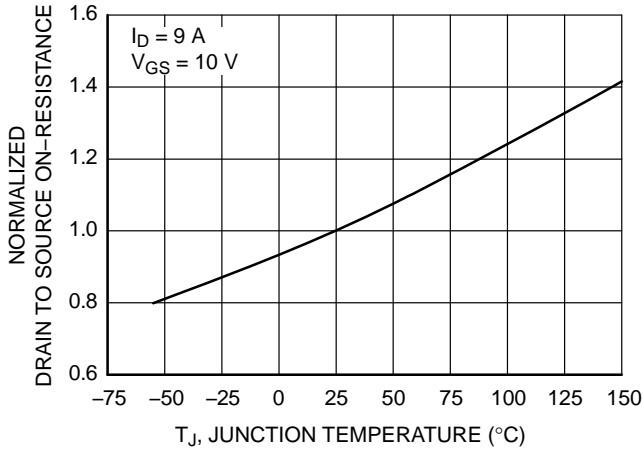


Figure 15. Normalized On Resistance vs. Junction Temperature

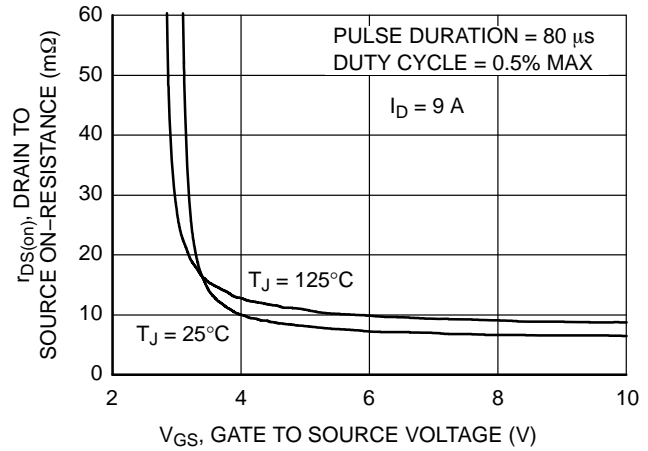


Figure 16. On-Resistance vs. Gate to Source Voltage

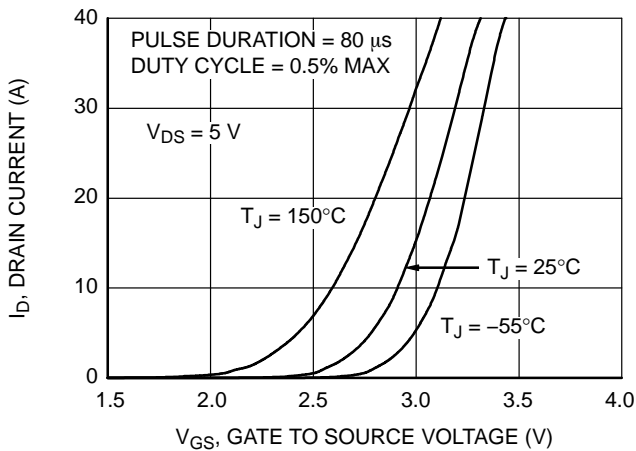


Figure 17. Transfer Characteristics

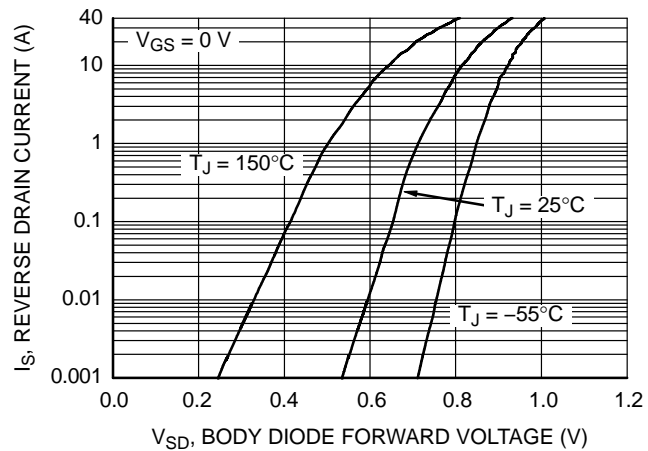


Figure 18. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (Q2 N-CHANNEL) ($T_J = 25^\circ\text{C}$, unless otherwise noted) (continued)

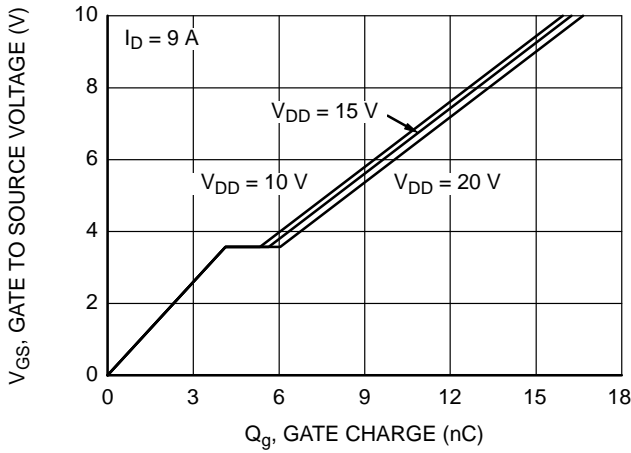


Figure 19. Gate Charge Characteristics

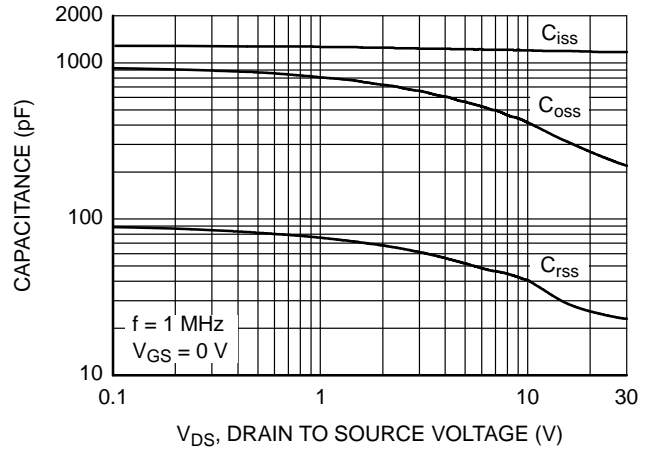


Figure 20. Capacitance vs. Drain to Source Voltage

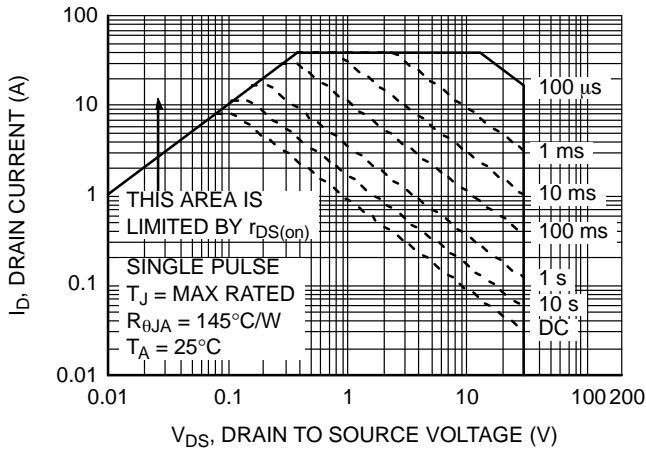


Figure 21. Forward Bias Safe Operating Area

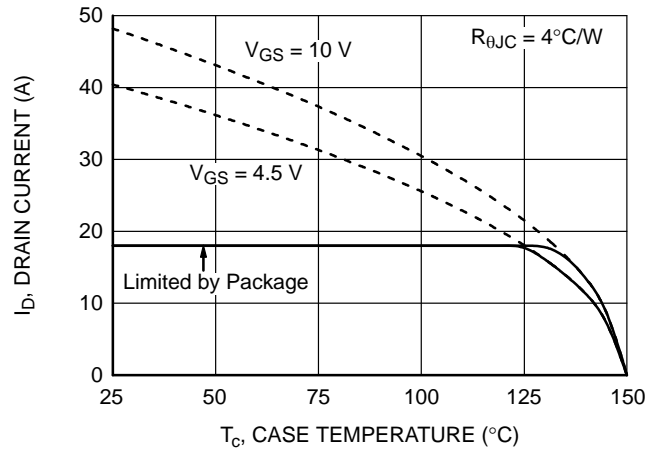


Figure 22. Maximum Continuous Drain Current vs. Case Temperature

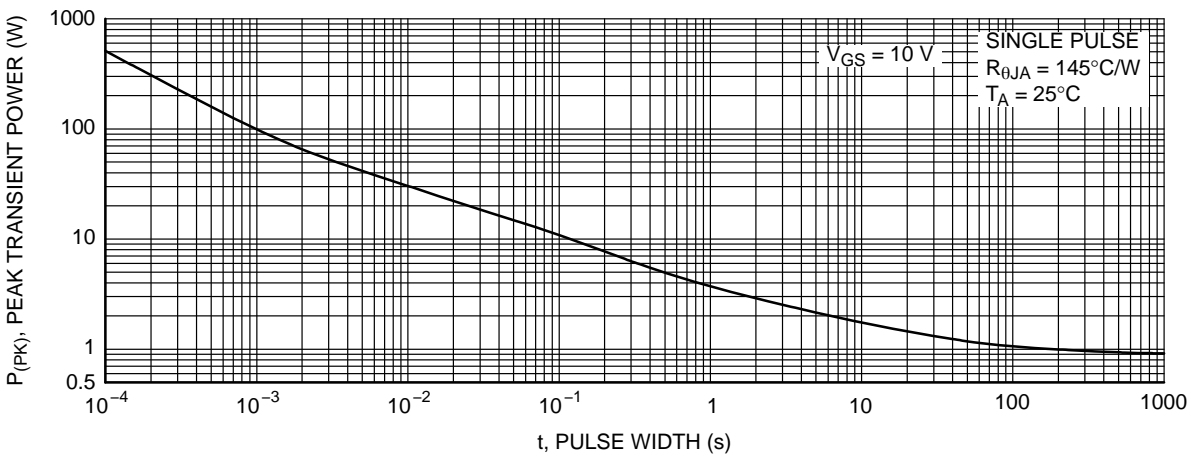


Figure 23. Single Pulse Maximum Power Dissipation

FDMC8200

TYPICAL CHARACTERISTICS (Q2 N-CHANNEL) ($T_J = 25^\circ\text{C}$, unless otherwise noted) (continued)

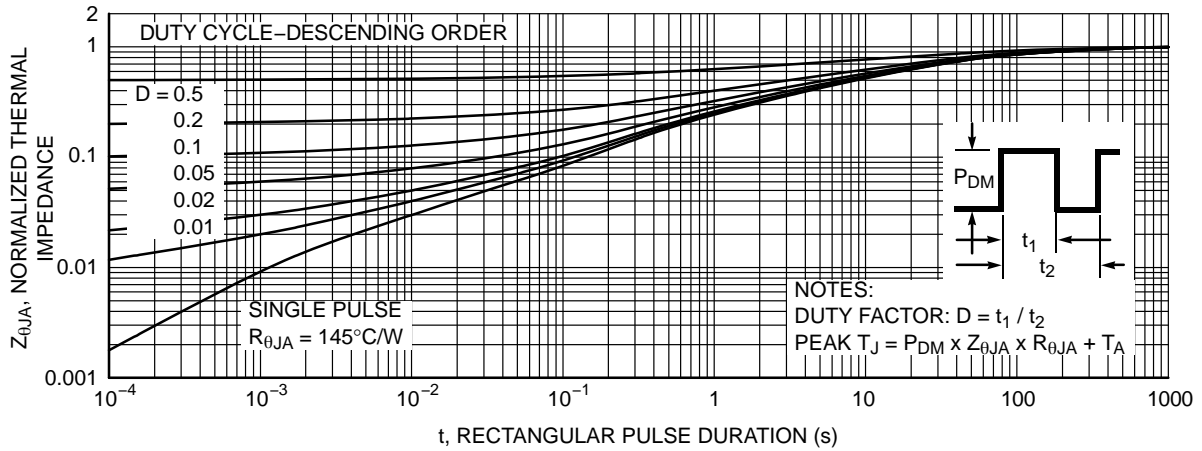


Figure 24. Junction-to-Ambient Transient Thermal Response Curve

PACKAGE MARKING AND ORDERING INFORMATION

| Device | Device Marking | Package | Reel Size | Tape Width | Shipping [†] |
|----------|----------------|--|-----------|------------|-----------------------|
| FDMC8200 | FDMC8200 | WDFN8 3x3, 0.65P (Power 33) (Pb-Free, Halide Free) | 13" | 12 mm | 3000 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

POWERTRENCH is registered trademark of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries.

MECHANICAL CASE OUTLINE

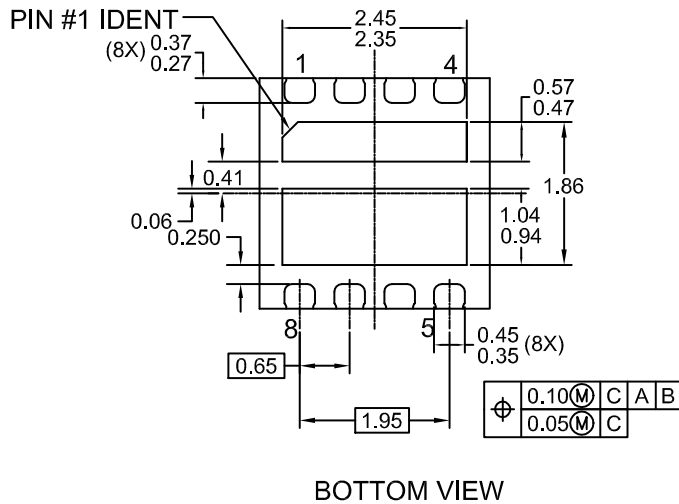
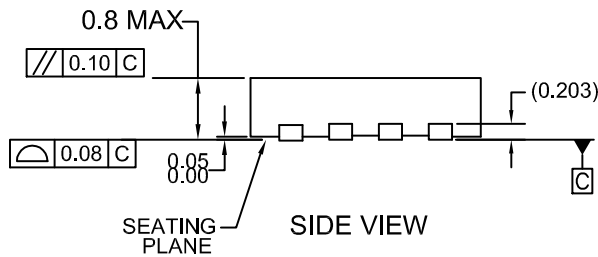
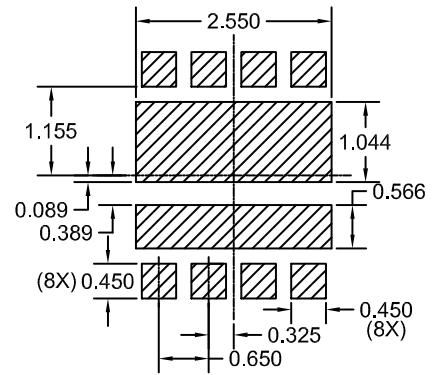
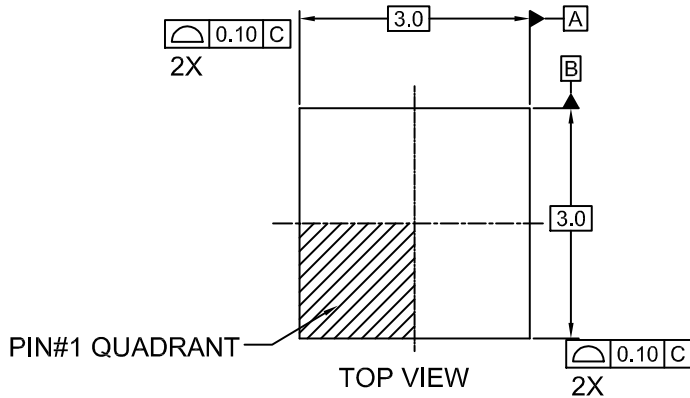
PACKAGE DIMENSIONS

ON Semiconductor®



WDFN8 3x3, 0.65P
CASE 511DE
ISSUE O

DATE 31 AUG 2016



NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

| | | |
|-------------------------|-------------------------|--|
| DOCUMENT NUMBER: | 98AON13621G | Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. |
| DESCRIPTION: | WDFN8 3X3, 0.65P | PAGE 1 OF 1 |

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, **Onsemi**, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "**onsemi**" or its affiliates and/or subsidiaries in the United States and/or other countries. **onsemi** owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of **onsemi**'s product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. **onsemi** reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and **onsemi** makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT

North American Technical Support:

Voice Mail: 1 800-282-9855 Toll Free USA/Canada

Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

